

**Search Notes**

Application/Control No.

10/813,932

Examiner

Steven S. Paik

Applicant(s)/Patent under  
Reexamination

SCHROER, DAN J.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	385		
	375		
	380,382		
	435		
	462.01		
	487		
283	74, 109	8/1/2005	SSP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST		
Text search	8/1/2005	SSP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner